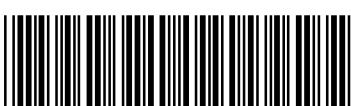


<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10769510	ENEBOE ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Vuthe Siek	2825

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
716	1,2,8,12-17	2/26/08	VS

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST ALL DATABASES (SEE SEARCH PRINTOUTS)	2/26/08	VS
SEE INTERFERENCE SEARCH REPORT PRINTOUT	2/26/08	VS

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
716	1,2,16,17	2/26/08	VS